

August 2012

FDD1600N10ALZ

N-Channel PowerTrench[®] MOSFET 100V, 6.8A, 160m Ω

Features

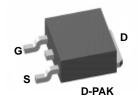
- $R_{DS(on)} = 124m\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 3.5A$
- $R_{DS(on)} = 175 m\Omega$ (Typ.)@ $V_{GS} = 5.0 V$, $I_{D} = 2.1 A$
- Low Gate Charge (Typ.2.78nC)
- Low C_{rss} (Typ. 2.04pF)
- · Fast Switching
- 100% Avalanche Tested
- · Improved dv/dt Capability
- · RoHS Compliant

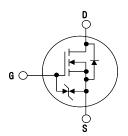
Description

This N-Channel MOSFET is produced using Fairchld Semiconductor's advance PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

- · DC to DC Converters
- · Synchronous Rectification for Telecommunication PSU
- · Battery Charger
- · AC motor drives and Uninterruptible Power Supplies





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter			FDD1600N10ALZ	Units	
V _{DSS}	Drain to Source Voltage			100	V	
V _{GSS}	Gate to Source Voltage			±20	V	
	- Continuous (T _C = 25°C)			6.8	^	
ID	Drain Current	- Continuous (T _C = 100°C)		4.3	A	
I _{DM}	Drain Current	- Pulsed	- Pulsed (Note 1)		Α	
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	5.08	mJ	
dv/dt	Peak Diode Recovery dv/	dt	(Note 3)	6.0	V/ns	
D	Dawer Dissipation	$(T_C = 25^{\circ}C)$		14.9	W	
P _D Power Dissipation		- Derate above 25°C		0.12	W/°C	
T _J , T _{STG}	Operating and Storage Te	Operating and Storage Temperature Range			°C	
T _L		Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			°C	

Thermal Characteristics

Symbol	Parameter FDD1600N		Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max	8.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max	87	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
1600N10ALZ	FDD1600N10ALZ	D-PAK	380mm	16mm	2500

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0V$, $T_C = 25^{\circ}C$	100	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.1	-	V/°C
1	Zoro Coto Voltago Proin Current	$V_{DS} = 80V, V_{GS} = 0V$	-	-	1	
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80V, T_{C} = 125^{\circ}C$	-	-	500	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±10	μА

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.4	2.1	2.8	V
R _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 3.5A$	-	124	160	mΩ	
	$V_{GS} = 5V, I_D = 2.1A$	-	175	375	11122	
g _{FS}	Forward Transconductance	$V_{DS} = 10V, I_{D} = 6.8A$	-	34	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 50V V 0V	-	169	225	pF
C _{oss}	Output Capacitance	$V_{DS} = 50V, V_{GS} = 0V$ $f = 1MHz$	-	43	55	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	-	2.04	-	pF
C _{oss(er)}	Energy Related Output Capacitance	$V_{DS} = 50V, I_{D} = 6.8A$		85	-	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	2.78	3.61	nC
Q _{g(tot)}	Total Gate Charge at 5V	$V_{DS} = 50V I_{D} = 6.8A$		1.5	1.95	nC
Q_{gs}	Gate to Source Gate Charge	V _{GS} = 10V	-	0.72	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	(Note 4	-	0.56	-	nC
ESR	Equivalent Series Resistance (G-S)	f = 1MHZ	-	2.1	-	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			=	7	24	ns
t _r	Turn-On Rise Time	$V_{DD} = 50V, I_{D} = 6.8A$		-	2	14	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 4.7\Omega$		-	13	36	ns
t _f	Turn-Off Fall Time		(Note 4)	-	2	14	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	6.8	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	27.2	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 6.8A$	-	-	1.3	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V$, $I_{SD} = 6.8A$, $V_{DS} = 50V$	-	37	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	42	-	nC

Notes:

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 1mH, I_{AS} =3.18A, R_G = 25 Ω , Starting T_J = 25 $^{\circ}C$
- 3. $I_{SD} \le 6.8 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

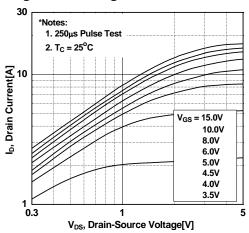


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

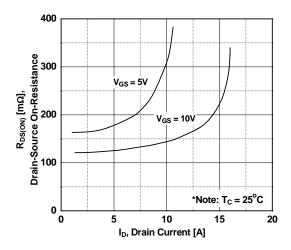


Figure 5. Capacitance Characteristics

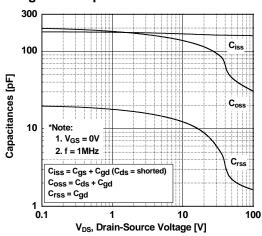


Figure 2. Transfer Characteristics

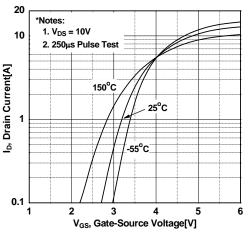


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

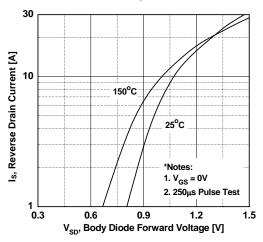
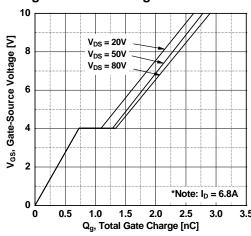


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

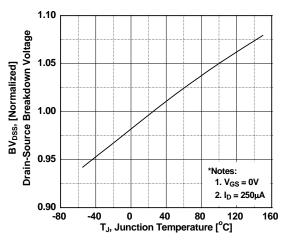


Figure 9. Maximum Safe Operating Area vs. Case Temperature

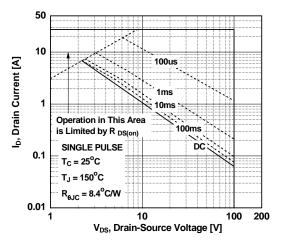


Figure 11. Eoss vs. Drain to Source Voltage

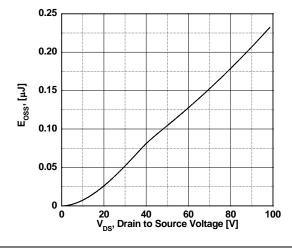


Figure 8. On-Resistance Variation vs. Temperature

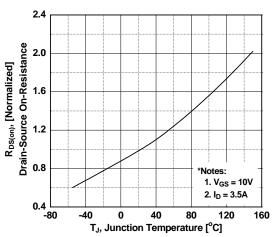


Figure 10. Maximum Drain Current

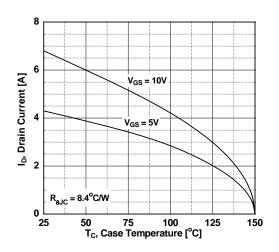
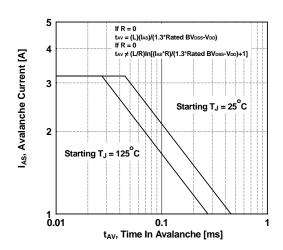
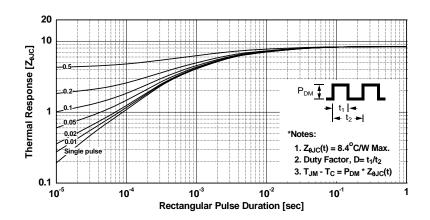


Figure 12. Unclamped Inductive Switching Capability



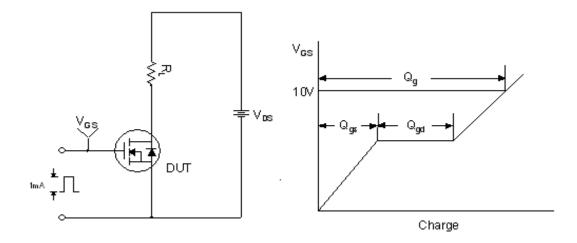
Typical Performance Characteristics (Continued)



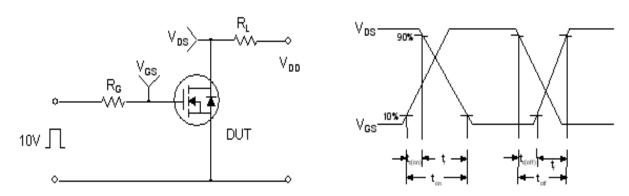


 $V_{DS}(t)$

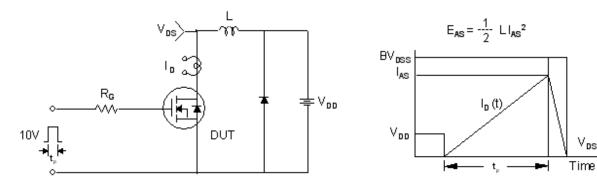
Gate Charge Test Circuit & Waveform



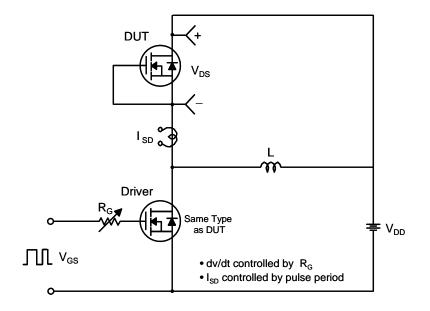
Resistive Switching Test Circuit & Waveforms

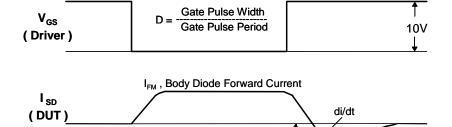


Unclamped Inductive Switching Test Circuit & Waveforms



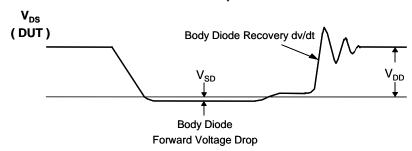
Peak Diode Recovery dv/dt Test Circuit & Waveforms





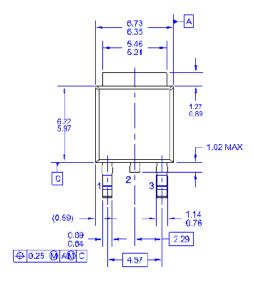
Body Diode Reverse Current

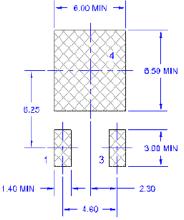
 \mathbf{I}_{RM}



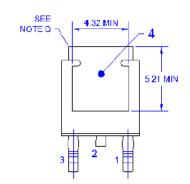
Mechanical Dimensions

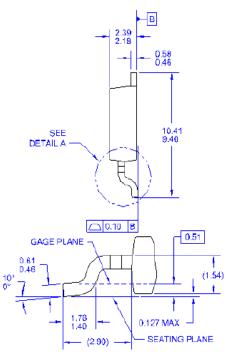
D-PAK





LAND PATTERN RECOMMENDATION





- NOTES: UNLESS OTHERWISE SPECIFIED

 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252.

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 C) DIMENSIONING AND FOLERANCING PER ASME YH-3-M-194.
 D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION,
 E) PRESENCE OF TRIMINED CENTER LEAD IS COTIONAL.
 F) DIMENSIONS ARE EXCLUSSIVE OF BURSS, WOLD FLASH AND ITE BAR EX IRUSIONS.
 C) LAND PATTERNIRECOMENDATION 16 BASED ON IPC7951A STD TO220P1003X239-3N,
 H) DRAWING NUMBER AND REVISION: WKT-TO252A03REVB

Dimensions in Millimeters





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